

PMEG2010BELD

20 V, 1 A low VF MEGA Schottky barrier rectifier Rev. 1 — 18 April 2012 Pro

Product data sheet

Product profile

1.1 General description

Planar Maximum Efficiency General Application (MEGA) Schottky barrier rectifier with an integrated guard ring for stress protection, encapsulated in a leadless ultra small DFN1006D-2 (SOD882D) Surface-Mounted Device (SMD) plastic package with visible and solderable side pads.

1.2 Features and benefits

- Average forward current: I_{F(AV)} ≤ 1 A
- Reverse voltage: V_R ≤ 20 V
- Low forward voltage V_F ≤ 490 mV
- AEC-Q101 qualified

- Ultra small and leadless SMD plastic package
- Solderable side pads
- Package height typ. 0.37 mm

1.3 Applications

- Low voltage rectification
- High efficiency DC-to-DC conversion
- Switch mode power supply
- Reverse polarity protection
- Low power consumption applications
- Ultra high-speed switching
- LED backlight for mobile application

1.4 Quick reference data

Quick reference data Table 1.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$I_{F(AV)}$	average forward current	δ = 0.5 ; f = 20 kHz; $T_{amb} \le$ 80 °C; square wave	<u>[1]</u>	-	-	1	Α
		δ = 0.5 ; f = 20 kHz; $T_{sp} \le$ 130 °C; square wave		-	-	1	Α
V_R	reverse voltage	T _j = 25 °C		-	-	20	V
V _F	forward voltage	I_F = 1 A; pulsed; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = 25 °C		-	428	490	mV
I _R	reverse current	V _R = 10 V; T _j = 25 °C		-	28	50	μΑ
t _{rr}	reverse recovery time	$I_R = 0.5 \text{ A}; I_F = 0.5 \text{ A}; I_{R(meas)} = 0.1 \text{ A};$ $T_j = 25 ^{\circ}\text{C}$		-	1.6	-	ns

^[1] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode[1]		. 54 -
2	Α	anode	1 2	1 1 2
			Transparent top view	sym001
			DFN1006D-2 (SOD882D)	

^[1] The marking bar indicates the cathode.

3. Ordering information

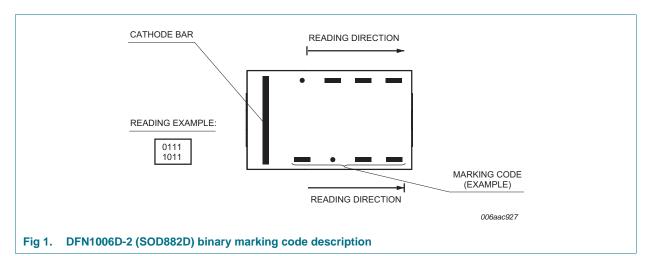
Table 3. Ordering information

Type number	Package			
	Name	Description	Version	
PMEG2010BELD	DFN1006D-2	Leadless ultra small plastic package; 2 terminals	SOD882D	

4. Marking

Table 4. Marking codes

Type number	Marking code
PMEG2010BELD	0000 1001



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5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_R	reverse voltage	$T_j = 25 ^{\circ}C$		-	20	V
I _F	forward current	T _{sp} ≤ 130 °C		-	1	Α
$I_{F(AV)}$	average forward current	δ = 0.5 ; f = 20 kHz; square wave; $T_{amb} \le 80 ^{\circ}\text{C}$	<u>[1]</u>	-	1	Α
		δ = 0.5 ; f = 20 kHz; square wave; T _{sp} ≤ 130 °C		-	1	Α
I _{FRM}	repetitive peak forward current	$t_p \le 1 \text{ ms}; \delta \le 0.25$		-	3	А
I _{FSM}	non-repetitive peak forward current	t_p = 8 ms; $T_{j(init)}$ = 25 °C; square wave		-	6	Α
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[2][3]	-	370	mW
			[4][3]	-	735	mW
			[1][3]	-	1135	mW
T _j	junction temperature			-	150	°C
T _{amb}	ambient temperature			-55	150	°C
T_{stg}	storage temperature			-65	150	°C

^[1] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	[1][4	[1][2][3]	-	-	340	K/W
			[1][4][3]	-	-	170	K/W
			[1][5][3]	-	-	110	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point		<u>6</u>	-	-	25	K/W

^[1] For Schottky barrier diodes thermal runaway has to be considered, as in some applications the reverse power losses P_R are a significant part of the total power losses.

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^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

^[3] Reflow soldering is the only recommended soldering method.

^[4] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for cathode 1 cm².

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

^[3] Reflow soldering is the only recommended soldering method.

^[4] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode 1 cm².

^[5] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

^[6] Soldering point of cathode tab.

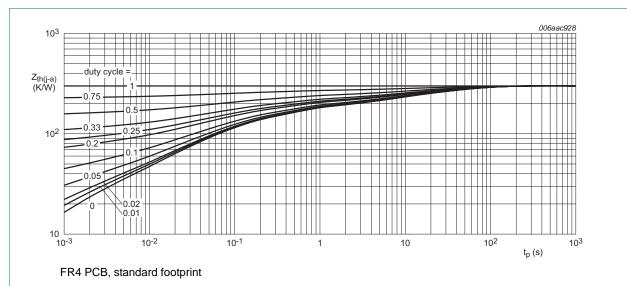


Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

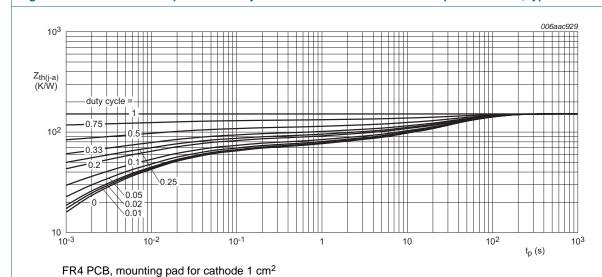
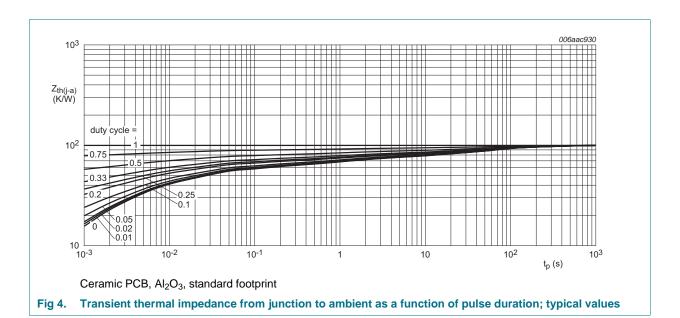


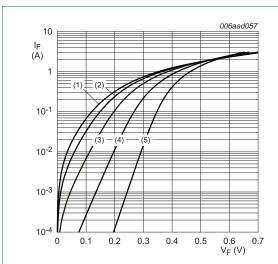
Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



7. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _F	forward voltage	I_F = 100 mA; pulsed; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = 25 °C	-	266	310	mV
		I_F = 500 mA; pulsed; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = 25 °C	-	353	390	mV
		I_F = 1 A; pulsed; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = 25 °C	-	428	490	mV
I _R	reverse current	$V_R = 10 \text{ V}; T_j = 25 \text{ °C}$	-	28	50	μA
		$V_R = 20 \text{ V}; T_j = 25 \text{ °C}$	-	87	200	μA
C_d	diode capacitance	V _R = 1 V; f = 1 MHz; T _j = 25 °C	-	31	40	pF
t _{rr}	reverse recovery time	$I_F = 0.5 \text{ A}$; $I_R = 0.5 \text{ A}$; $I_{R(meas)} = 0.1 \text{ A}$; $I_{j} = 25 \text{ °C}$	-	1.6	-	ns
V_{FRM}	forward recovery voltage	$I_F = 0.5 \text{ A}; \text{ d}I_F/\text{d}t = 20 \text{ A/}\mu\text{s}; T_j = 25 ^{\circ}\text{C}$	-	565	-	mV



(1)
$$T_i = 150 \, ^{\circ}C$$

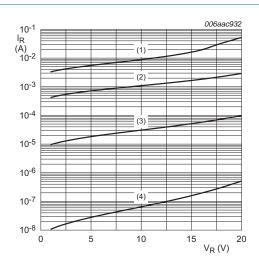
(2)
$$T_i = 125 \, ^{\circ}C$$

(3)
$$T_j = 85 \, ^{\circ}C$$

(4)
$$T_j = 25$$
 °C

(5)
$$T_j = -40 \, ^{\circ}\text{C}$$

Fig 5. Forward current as a function of forward voltage; typical values



(1)
$$T_j = 125 \, ^{\circ}C$$

(2)
$$T_i = 85 \, ^{\circ}C$$

(3)
$$T_j = 25 \, ^{\circ}C$$

(4)
$$T_j = -40 \, ^{\circ}C$$

Fig 6. Reverse current as a function of reverse voltage; typical values

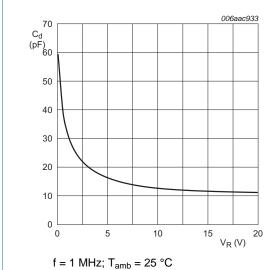
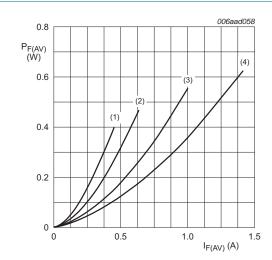


Fig 7. Diode capacitance as a function of reverse voltage; typical values



T_i = 150 °C

(1) $\delta = 0.1$

(2) $\delta = 0.2$

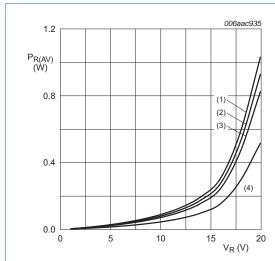
(3) $\delta = 0.5$

(4) $\delta = 1$

Fig 8. Average forward power dissipation as a function of average forward current; typical values

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T_i = 125 °C

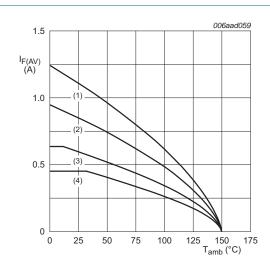
(1) $\delta = 1$ (DC)

(2) $\delta = 0.9$; f = 20 kHz

(3) $\delta = 0.8$; f = 20 kHz

(4) $\delta = 0.5$; f = 20 kHz

Fig 9. Average reverse power dissipation as a function of reverse voltage; typical values



FR4 PCB, standard footprint

 $T_j = 150 \, ^{\circ}C$

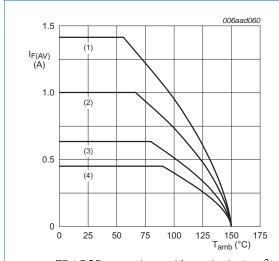
(1) $\delta = 1$

(2) $\delta = 0.5$

(3) $\delta = 0.2$

(4) $\delta = 0.1$

Fig 10. Average forward current as a function of ambient temperature; typical values



FR4 PCB, mounting pad for cathode 1 cm²

T_i = 150 °C

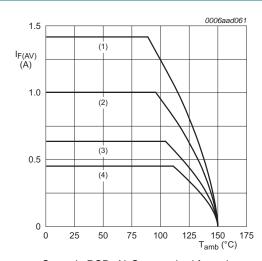
(1) $\delta = 1$

(2) $\delta = 0.5$

(3) $\delta = 0.2$

(4) $\delta = 0.1$

Fig 11. Average forward current as a function of ambient temperature; typical values



Ceramic PCB, Al₂O₃, standard footprint

T_i = 150 °C

(1) $\delta = 1$

(2) $\delta = 0.5$

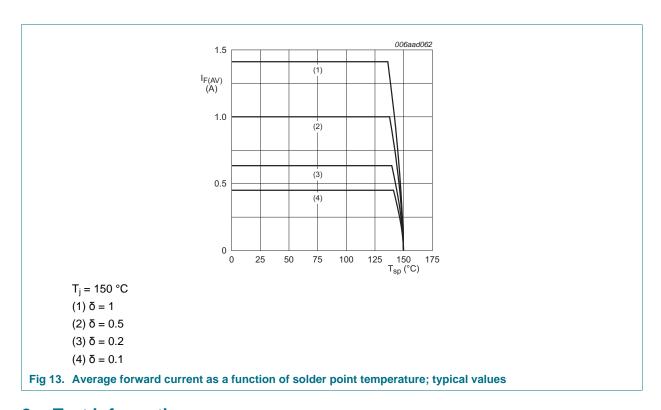
(3) $\delta = 0.2$

(4) $\delta = 0.1$

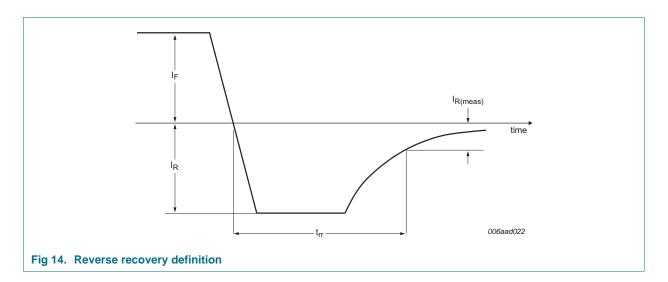
Fig 12. Average forward current as a function of ambient temperature; typical values

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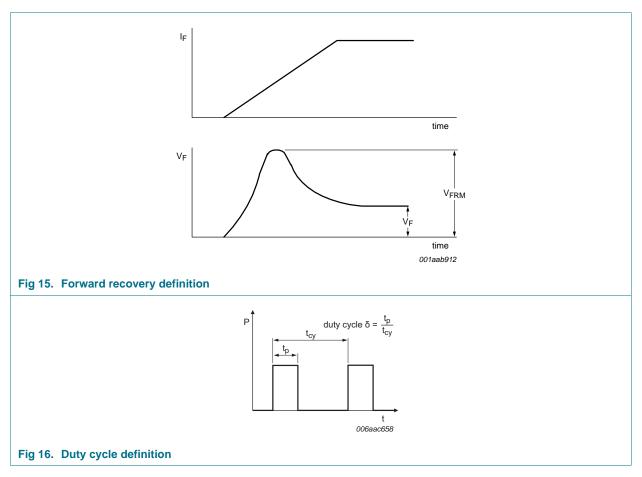
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8. Test information



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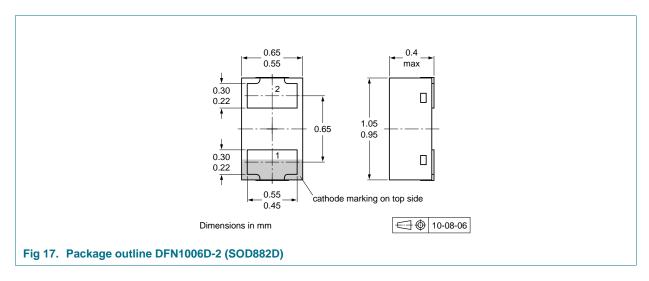
The current ratings for the typical waveforms are calculated according to the equations: $I_{F(AV)} = I_M \times \delta$ with I_M defined as peak current, $I_{RMS} = I_{F(AV)}$ at DC, and $I_{RMS} = I_M \times \sqrt{\delta}$ with I_{RMS} defined as RMS current.

8.1 Quality information

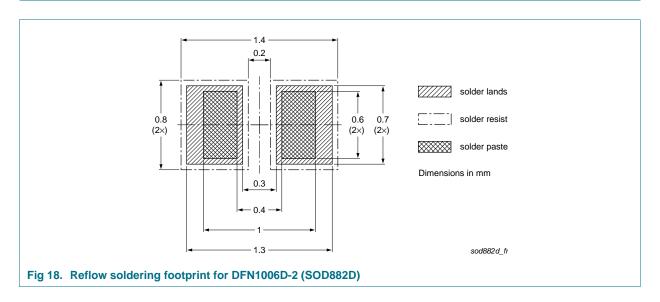
This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

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9. Package outline



10. Soldering



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11. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMEG2010BELD v.1	20120418	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1] [2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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20 V, 1 A low VF MEGA Schottky barrier rectifier

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